

## 2X Faster measurement speed\*

For the production of tunable laser sources and tunable optical transceivers, high speed measurement and processing capability are required. The AQ6150 series can acquire, analyze and transfer a measurement to a PC within 0.2 seconds.

\*Compared with our previous models.



Model		Wavelength	Accuracy	Maximum number of wavelengths	Application
High accuracy model <b>AQ6151B</b>	Standard	1270 to 1650 nm	±0.2 ppm	1024 (Multi-wavelength) 1 (Single-wavelength)	Adjustment, characterization, and inspection of laser chips, tunable lasers, WDM transmission systems, etc.
	Extended	1200 to 1700 nm			
	Wide range	900 to 1700 nm			
Standard model <b>AQ6150B</b>	Standard	1270 to 1650 nm	±0.7 ppm	1024 (Multi-wavelength) 1 (Single-wavelength)	Inspection of DFB-LDs, tunable lasers, optical transceivers. WDM transmission systems
	Extended	1200 to 1700 nm			
	Wide range	900 to 1700 nm			

